## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination

10523901

MATTES ET AL.

Examiner

Art Unit

Radkiewicz, Jared W

2624

## SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Text search for pupil adj (size or radius or dimension or diameter) with age	9/24/2007	JWR

INTERFERENCE SEARCH				
Class	Subclass	Date	Examine	